Power MOSFET

30 V, 23 A, Single N-Channel, SO-8 Flat Lead

Features

- Low R_{DS(on)}
- Low Inductance SO-8 Package
- These are Pb-Free Devices

Applications

- Notebooks, Graphics Cards
- DC-DC Converters
- Synchronous Rectification

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Paramet	er		Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain Current	Steady	T _A = 25°C	I _D	14	Α
(Note 1)	State	T _A = 85°C		10	
	t ≤10 s	T _A = 25°C		23	
Power Dissipation (Note 1)	Steady State T _A = 25°C		P _D	2.2	W
	t ≤10 s			5.8	
Continuous Drain Current	011	T _A = 25°C	I _D	9.1	Α
(Note 2)	Steady State	T _A = 85°C		6.5	
Power Dissipation (Note 2)		T _A = 25°C	P_{D}	0.9	W
Pulsed Drain Current	t _p =	t _p = 10 μs		68	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 150	°C
Source Current (Body Diode)			I _S	7.0	Α
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 30 V, V_{GS} = 10 V, I_{PK} = 21 A, L = 1 mH, R_G = 25 Ω)			E _{AS}	220	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	56.3	°C/W
Junction-to-Ambient - t ≤10 s (Note 1)	$R_{\theta JA}$	21.5	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	141.6	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

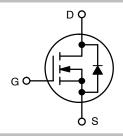
- Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- Surface mounted on FR4 board using the minimum recommended pad size (Cu area = 0.0264 in sq).



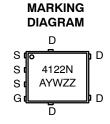
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V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX (Note 1)
30 V	4.6 mΩ @ 10 V	23 A
55 v	6.3 mΩ @ 4.5 V	257







4122N = Specific Device Code A = Assembly Location

Y = Year W = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4122NT1G	SO-8 FL (Pb-Free)	1500 Tape & Reel
NTMFS4122NT3G	SO-8 FL (Pb-Free)	5000 Tape & Reel

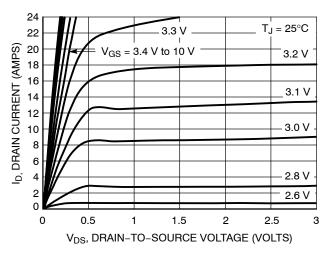
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				<u>-</u>	<u>-</u>	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 2	250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				23		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V 0VV 04V	$T_J = 25^{\circ}C$			1.0	μΑ
		V _{GS} = 0 V, V _{DS} = 24 V	T _J = 125°C			10	1
Gate-to-Source Leakage Current	I_{GSS}	$V_{DS} = 0 V, V_{GS} =$	= 20 V			100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μΑ	1.0		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D =	V _{GS} = 10 V, I _D = 14 A		4.6	6.0	mΩ
		V _{GS} = 4.5 V, I _D =	= 12 A		6.3	8.5	1
Forward Transconductance	g _{FS}	V _{DS} = 15 V, I _D = 10 A			13.2		S
CHARGES, CAPACITANCES AND GATE R	ESISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 24 V			2310		pF
Output Capacitance	C _{OSS}				460		
Reverse Transfer Capacitance	C _{RSS}				263		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 12 A			20	30	nC
Threshold Gate Charge	Q _{G(TH)}				3.0		1
Gate-to-Source Charge	Q_{GS}				6.7]
Gate-to-Drain Charge	Q_{GD}				8.1		1
Gate Resistance	R_{G}				0.7		Ω
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(ON)}				20		ns
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} :	= 15 V,		20		1
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_D = 1.0 A, R_L = 15 Ω , R_G = 3.0 Ω			30		1
Fall Time	t _f				31		1
DRAIN-SOURCE DIODE CHARACTERISTI	cs						
Forward Diode Voltage	V_{SD}	., .,,	T _J = 25°C		0.75	1.0	V
		$V_{GS} = 0 \text{ V}, I_S = 7.0 \text{ A}$	T _J = 125°C		0.6		1
Reverse Recovery Time	t _{RR}				28		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 7.0 \text{ A}$			14		1
Discharge Time	t _b				14		1
Reverse Recovery Charge	Q _{RR}				23		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

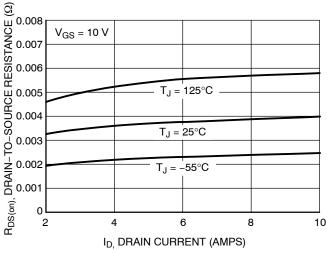
TYPICAL PERFORMANCE CURVES



24 $V_{DS} = 30 \text{ V}$ 22 ID, DRAIN CURRENT (AMPS) 20 18 16 14 12 10 8 $T_J = 125^{\circ}C$ 6 4 $T_J = 25^{\circ}C$ 2 $T_J = -55^{\circ}C$ 0 2 4 5 1 V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



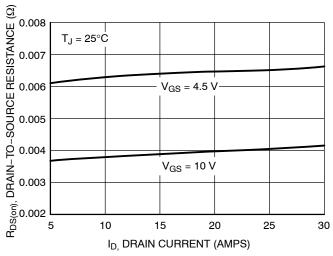
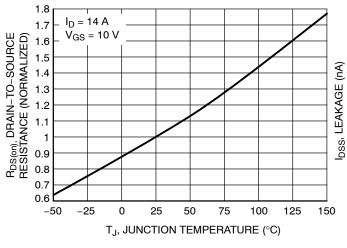


Figure 3. On-Resistance vs. Drain Current

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



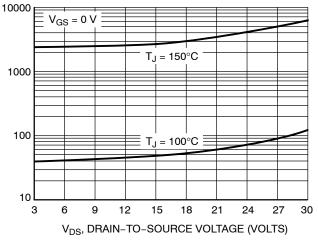


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES

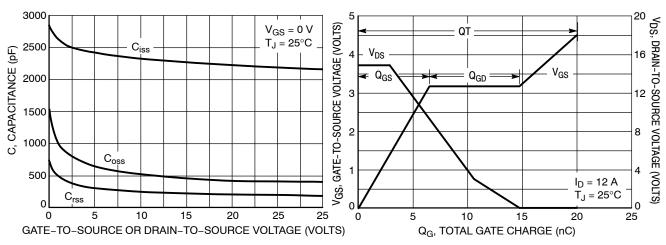


Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

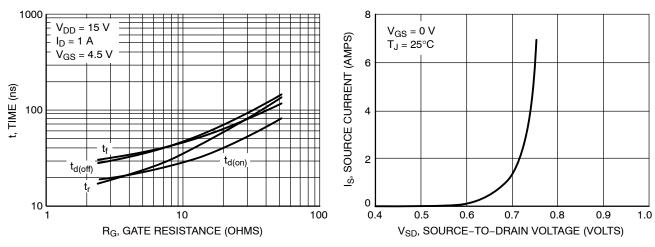


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

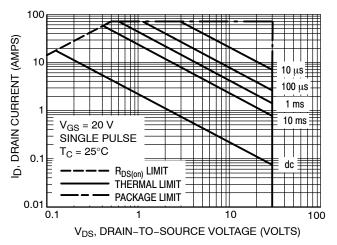


Figure 11. Maximum Rated Forward Biased Safe Operating Area





DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE N**

DATE 25 JUN 2018

NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е	1.27 BSC				
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40	3.80		
θ	0 °		12 °		

GENERIC MARKING DIAGRAM*

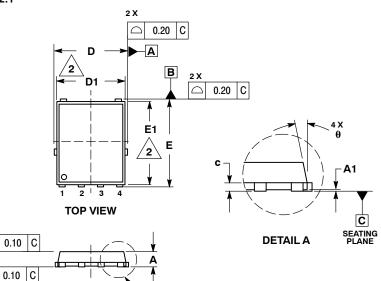


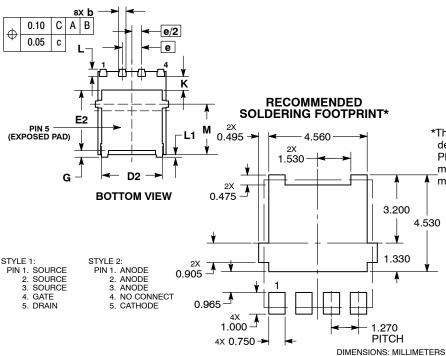
XXXXXX = Specific Device Code

= Assembly Location Α

Υ = Year W = Work Week ZZ = Lot Traceability

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





DETAIL A

SIDE VIEW

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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ſ	DESCRIPTION:	DFN5 5x6, 1.27P (SO-8FL)		PAGE 1 OF 1	

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